

Understanding Open Loop Output Impedance of the PGA900 DAC Gain Amplifier

Miro Oljaca, Collin Wells, Tim Green

Enhanced Industrial and Precision Analog

ABSTRACT

The open-loop output impedance (Z_o) of an operational amplifier is one of the most important specifications. Proper understanding of Z_o over frequency is crucial for the understanding of loop gain, bandwidth, and stability analysis.

This application note provides an in-depth understanding of the PGA900 Z_o magnitude over frequency. The effects of temperature, power supply voltage, and semiconductor process variation on the Z_o curve were observed. The variation over these parameters was used to develop a worst-case model that can be used to create robust designs.

Contents

1	PGA900 Z_o	2
2	Temperature Effects on PGA900 Z_o	3
3	Power Supply Effects on the PGA900 Z_o	4
4	Common-Mode Voltage Effects on PGA900	5
5	Process Variation Effects on PGA900 Z_o	6
6	Worst Case	7
7	Conclusion	8
8	References	8

List of Figures

1	PGA900 Typical Magnitude of the Open-Loop Output Impedance Z_o	2
2	PGA900 Typical Phase of the Open-Loop Output Impedance Z_o	2
3	PGA900 $Z_o(s)$ vs Temperature.....	3
4	PGA900 $Z_o(s)$ vs Power Supply Voltage	4
5	PGA900 $Z_o(s)$ vs Common-Mode Voltage	5
6	PGA900 $Z_o(s)$ vs Process Variation.....	6
7	PGA900 Worst-Case $Z_o(s)$ vs Frequency	7
8	PGA900 Minimum and Maximum $Z_o(s)$ from Worst-Case Results.....	7

List of Tables

1	Summary of PGA900 Z_o	8
---	-------------------------------	---

1 PGA900 Z_o

Figure 1 shows the typical frequency behavior of the PGA900 Z_o magnitude, $|Z_o(s)|$. The PGA900 Z_o phase ($\phi(s)$) is shown in Figure 2.

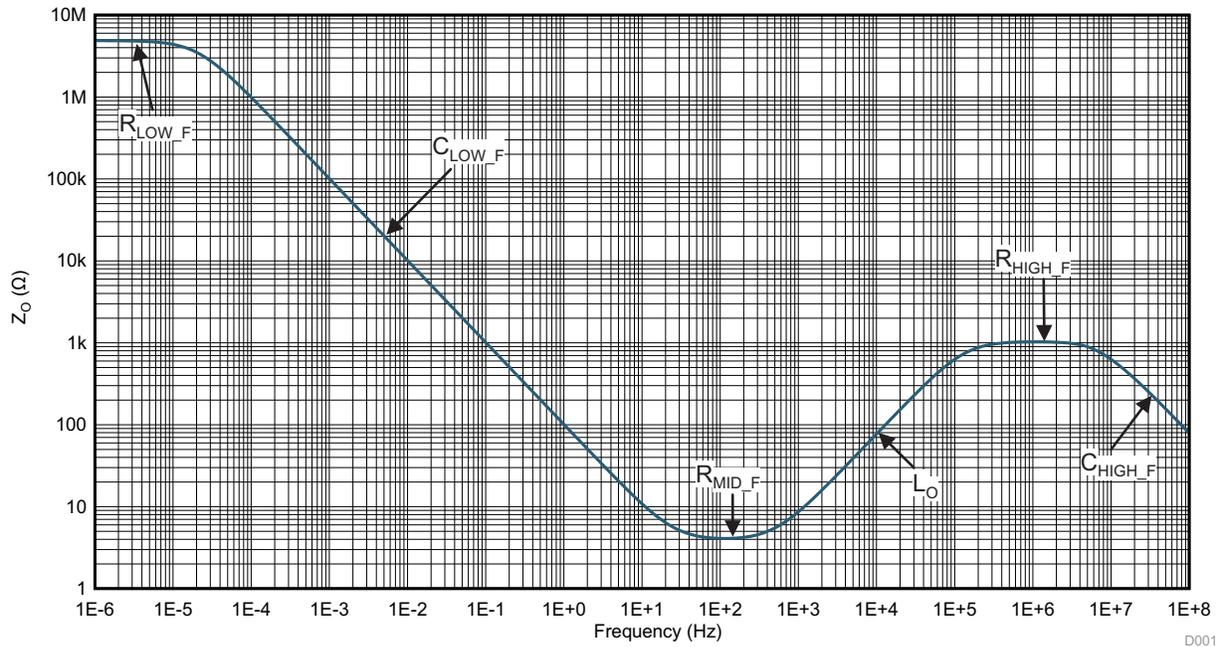


Figure 1. PGA900 Typical Magnitude of the Open-Loop Output Impedance Z_o

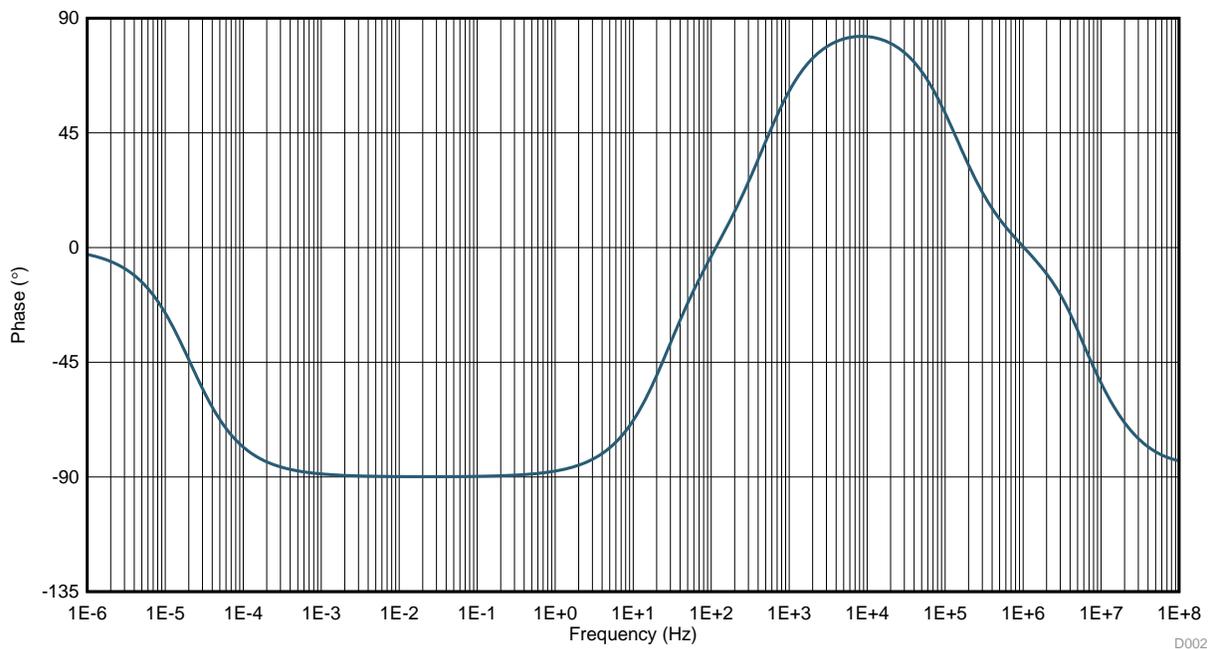


Figure 2. PGA900 Typical Phase of the Open-Loop Output Impedance Z_o

The PGA900 operational amplifier features a three-stage output stage architecture which results in the three distinct Z_o regions that can be seen in the Z_o magnitude. At low frequencies the Z_o curve is defined by a low frequency resistance value, R_{LOW_F} . As frequency increases Z_o becomes capacitive and Z_o in that region is defined by a low frequency capacitance value, C_{LOW_F} . At mid-frequencies, the Z_o becomes resistive again and is defined by a mid-frequency resistance value, R_{MID_F} . Z_o then becomes inductive and

will be defined by an open-loop inductance value, L_o . This inductive region is the most important for stability analysis because capacitive loading on the output can interact with the inductance resulting in stability issues that are difficult to compensate. The inductive region turns resistive again at higher frequencies and can be defined by a high frequency resistance value, R_{HIGH_F} . Finally, at the high frequencies near the end of the region of interest Z_o turns capacitive again and can be defined by a capacitance, C_{HIGH_F} .

Nominal values for the PGA900 operational amplifier Z_o are listed below:

- $R_{LOW_F} = 4.87 \text{ M}\Omega$
- $C_{LOW_F} = 1.57 \text{ mF}$
- $R_{MID_F} = 4.09 \text{ }\Omega$
- $L_o = 1.23 \text{ mH}$
- $R_{HIGH_F} = 1.03 \text{ k}\Omega$
- $C_{HIGH_F} = 20.14 \text{ pF}$

To create a robust design, it is important to understand how $|Z_o(s)|$ changes as the system operating conditions change. System operating conditions that affect the performance of the $|Z_o(s)|$ curve includes: temperature, power supply voltage, common-mode voltage and process variation.

2 Temperature Effects on PGA900 Z_o

The PGA900 is specified over an extended operating temperature range of -40°C to 150°C . The operating temperature affects the frequency behavior of the PGA900 $Z_o(s)$ over the full range of the curve as shown in Figure 3.

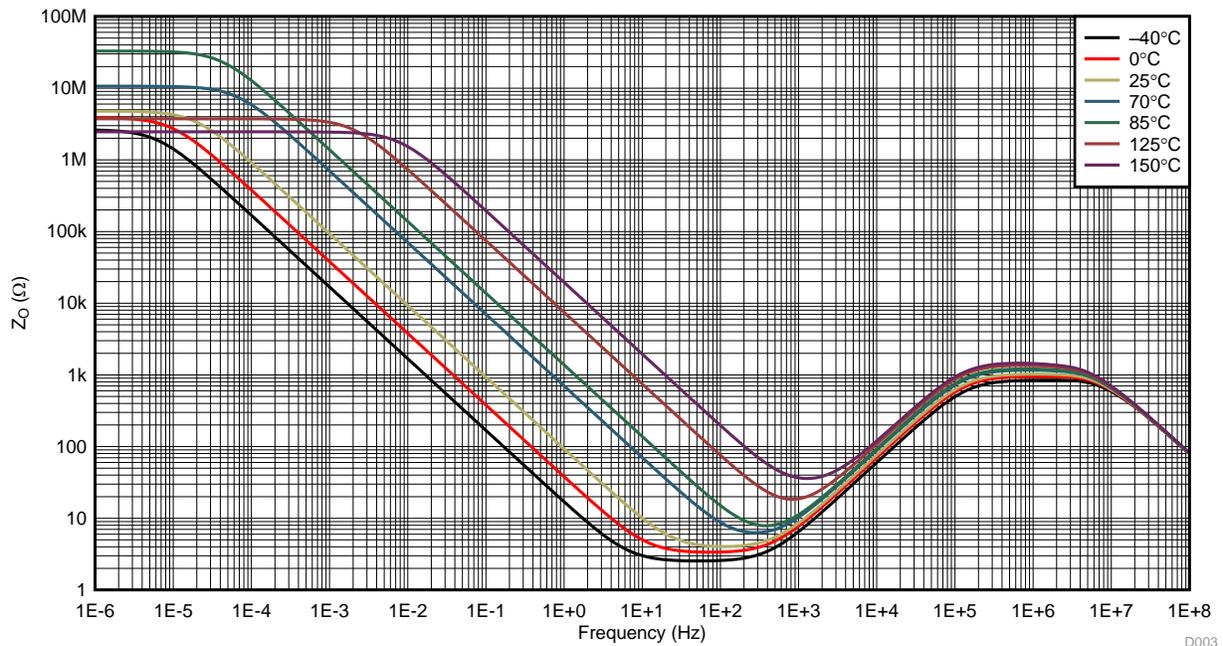


Figure 3. PGA900 $Z_o(s)$ vs Temperature

The Z_o parameter variations due to temperature are listed below:

- $R_{LOW_F} = 2.46 - 32.88 \text{ M}\Omega$
- $C_{LOW_F} = 0.82 - 9.46 \text{ mF}$
- $R_{MID_F} = 2.54 - 35.89 \text{ }\Omega$
- $L_o = 0.96 - 1.86 \text{ mH}$
- $R_{HIGH_F} = 0.84 - 1.46 \text{ k}\Omega$
- $C_{HIGH_F} = 19.49 - 20.20 \text{ pF}$

3 Power Supply Effects on the PGA900 Z_o

The PGA900 can operate over a wide range of the power supply voltages from 3.3 to 30 V. The power supply voltage has minimal impact on $Z_o(s)$ as shown in Figure 4.

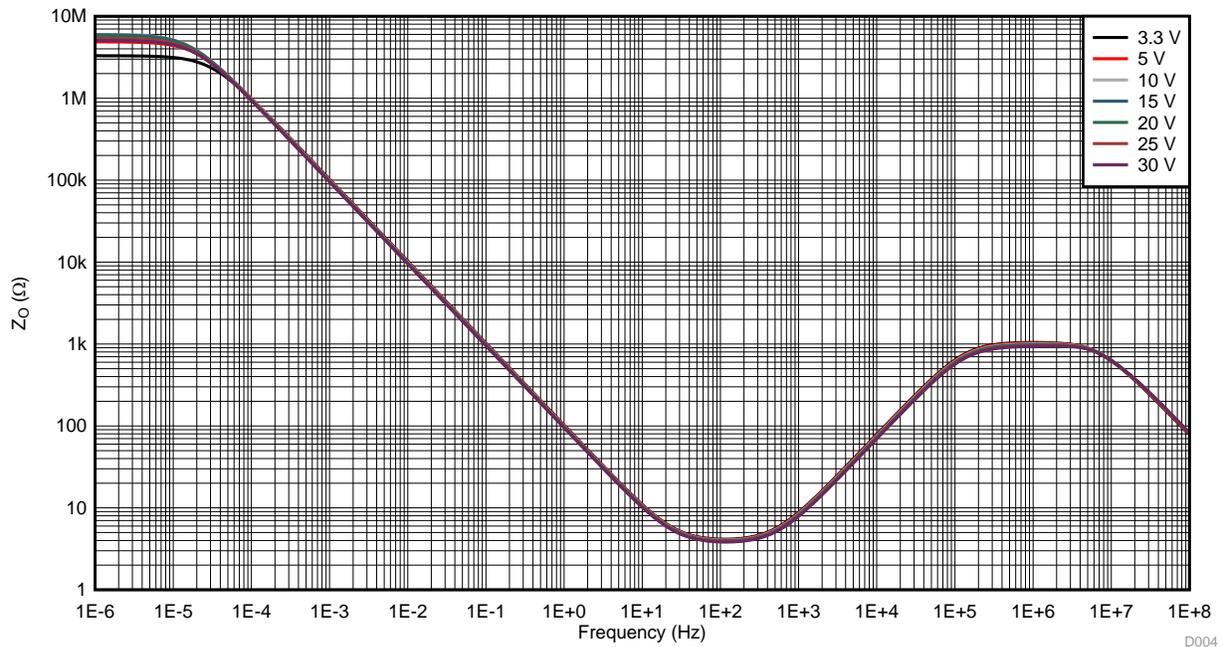


Figure 4. PGA900 $Z_o(s)$ vs Power Supply Voltage

The Z_o parameter variations due to power supply voltage are listed below:

- $R_{LOW_F} = 3.3 - 6.02 \text{ M}\Omega$
- $C_{LOW_F} = 1.55 - 1.68 \text{ mF}$
- $R_{MID_F} = 3.83 - 4.14 \text{ }\Omega$
- $L_O = 1.11 - 1.25 \text{ mH}$
- $R_{HIGH_F} = 0.94 - 1.04 \text{ k}\Omega$
- $C_{HIGH_F} = 19.32 - 20.52 \text{ pF}$

4 Common-Mode Voltage Effects on PGA900

The common-mode voltage of the PGA900 has some minimal effects on the $Z_O(s)$ as shown in Figure 5.

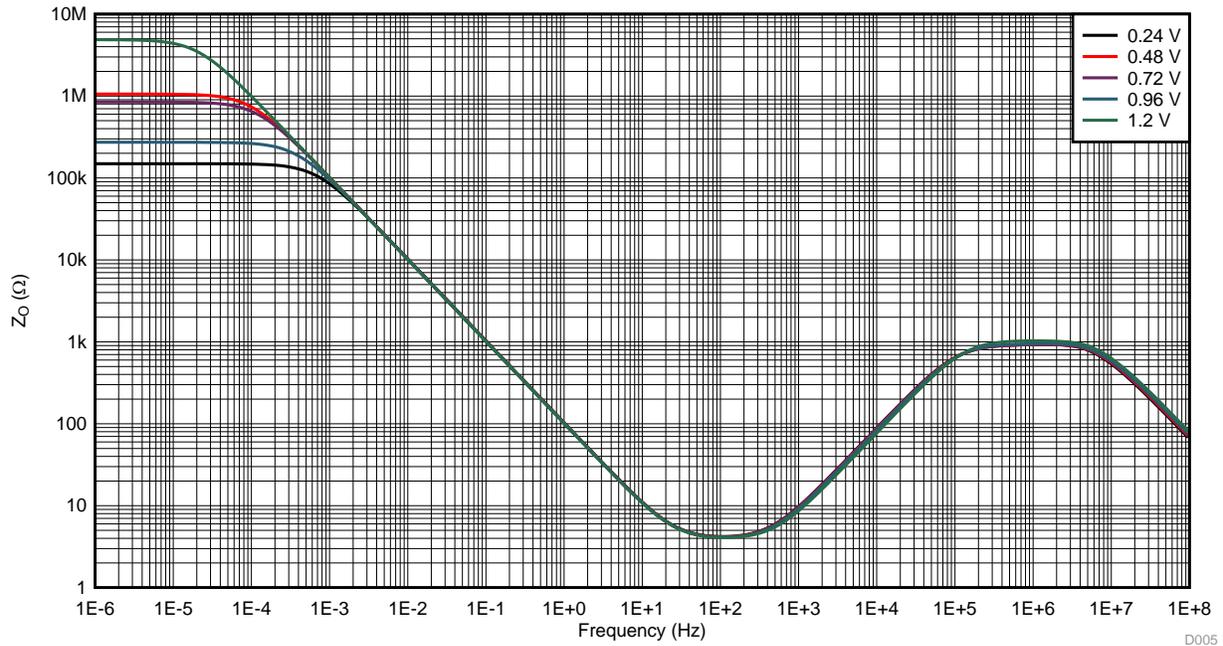


Figure 5. PGA900 $Z_O(s)$ vs Common-Mode Voltage

The Z_O parameter variations due to common-mode voltage are listed below:

- $R_{LOW_F} = 0.15 - 4.87 \text{ M}\Omega$
- $C_{LOW_F} = 1.56 - 1.88 \text{ mF}$
- $R_{MID_F} = 4.09 - 4.20 \text{ }\Omega$
- $L_O = 1.23 - 1.40 \text{ mH}$
- $R_{HIGH_F} = 0.93 - 1.03 \text{ k}\Omega$
- $C_{HIGH_F} = 20.14 - 24.31 \text{ pF}$

5 Process Variation Effects on PGA900 Z_o

During manufacturing, semiconductor process parameters are subjected to variations that result in performance differences in the final integrated circuits. Process corners represent the worst-case variations of these semiconductor parameters. The effects of the manufacturing process corners on the PGA900 $Z_o(s)$ are displayed in Figure 6.

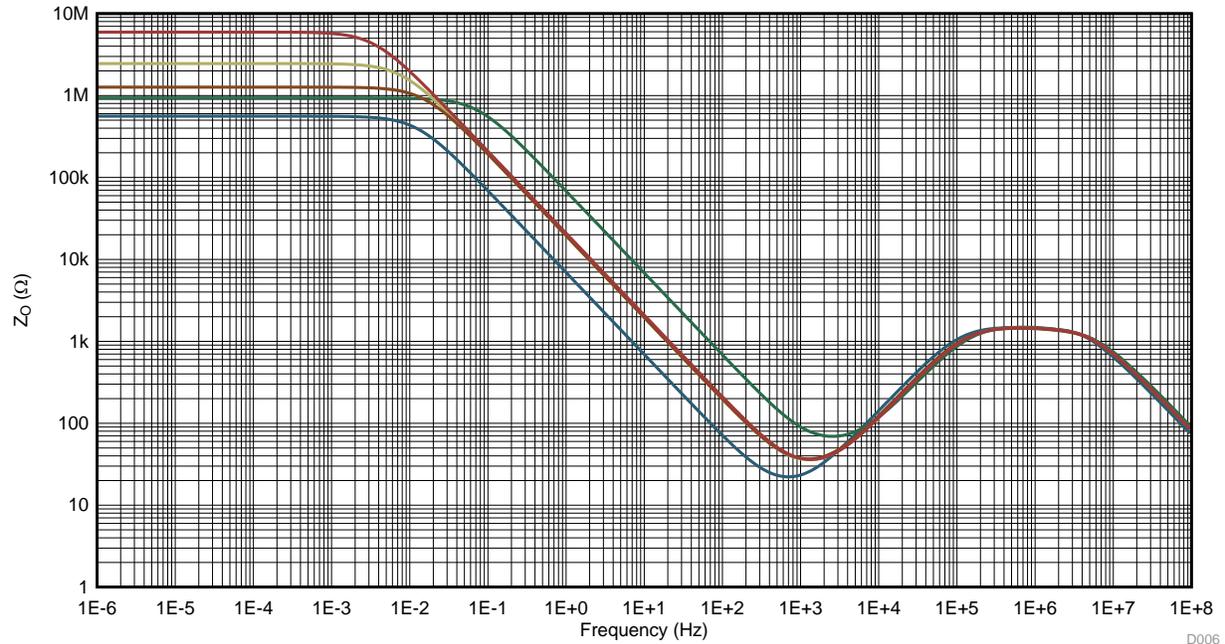


Figure 6. PGA900 $Z_o(s)$ vs Process Variation

The Z_o parameter variations due to process variation are listed below:

- $R_{LOW_F} = 0.35 - 5.95 \text{ M}\Omega$
- $C_{LOW_F} = 0.66 - 3.02 \text{ mF}$
- $R_{MID_F} = 3.07 - 5.64 \text{ }\Omega$
- $L_O = 1.1 - 1.26 \text{ mH}$
- $R_{HIGH_F} = 1.01 - 1.07 \text{ k}\Omega$
- $C_{HIGH_F} = 8.23 - 22.79 \text{ pF}$

6 Worst Case

The variations in the PGA900 $Z_o(s)$ due to temperature and process variations can be combined together to understand the worst-case variations that may occur in an application. The operating temperature results in the largest variations of $Z_o(s)$, while the power-supply voltage results in the smallest variations. The worst-case PGA900 $Z_o(s)$ can be observed in [Figure 7](#).

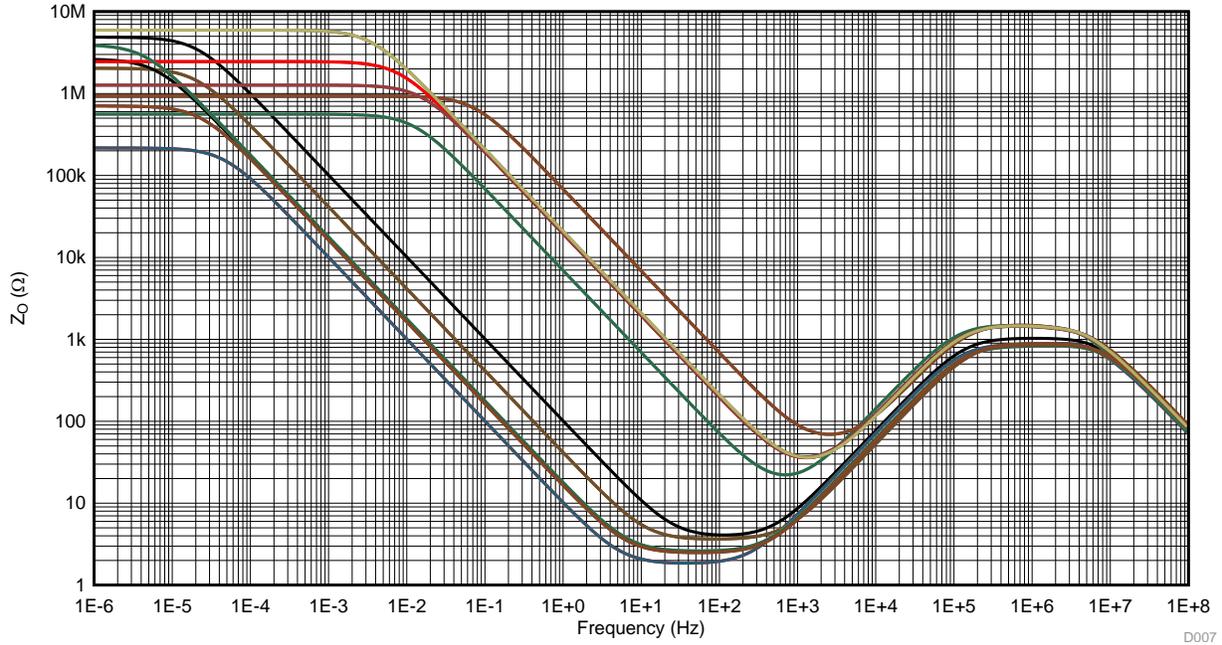


Figure 7. PGA900 Worst-Case $Z_o(s)$ vs Frequency

Taking the envelope of the minimum and maximum $Z_o(s)$ worst case results shows the possible variation of $Z_o(s)$ over several common application factors. The results are displayed in [Figure 8](#).

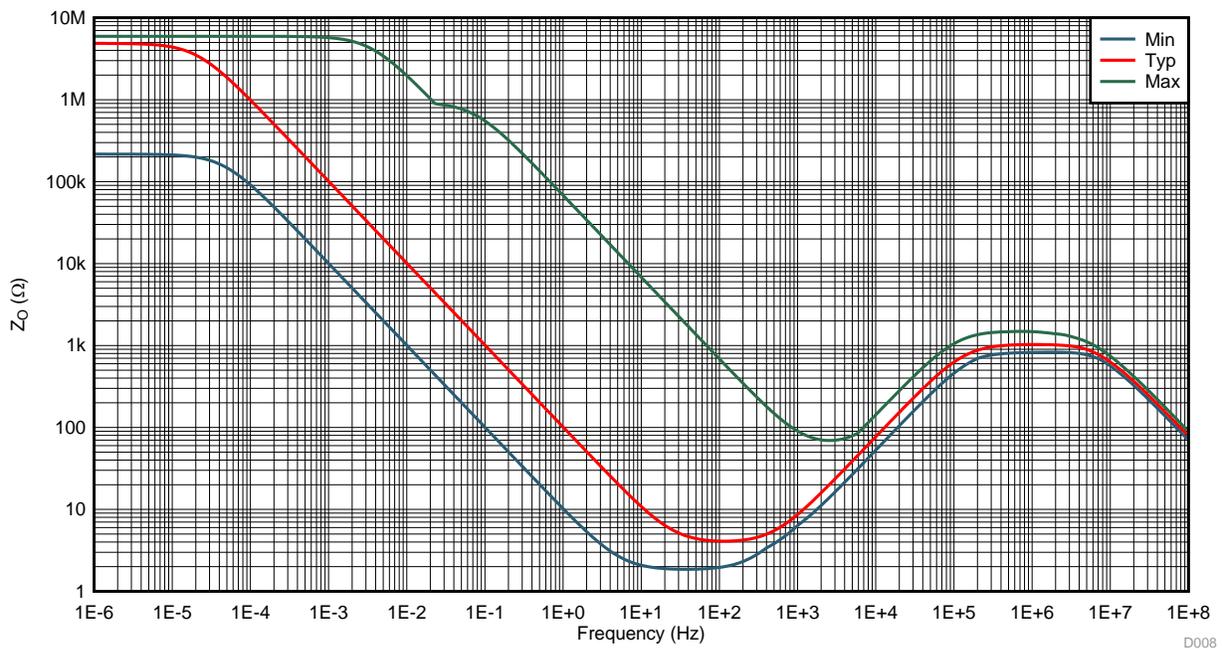


Figure 8. PGA900 Minimum and Maximum $Z_o(s)$ from Worst-Case Results

The Z_O parameter variations due to worst case are listed below:

- $R_{LOW_F} = 0.22 - 5.95 \text{ M}\Omega$
- $C_{LOW_F} = 0.002 - 15.81 \text{ mF}$
- $R_{MID_F} = 1.86 - 69.28 \text{ }\Omega$
- $L_O = 0.84 - 2.17 \text{ mH}$
- $R_{HIGH_F} = 0.83 - 1.49 \text{ k}\Omega$
- $C_{HIGH_F} = 17.76 - 22.69 \text{ pF}$

7 Conclusion

The PGA900 Z_O curve is shaped by three resistive regions, two capacitive regions and one inductive region. The complete PGA900 Z_O curve is shown in [Figure 1](#) and [Figure 2](#).

The Z_O curve changes due to variations in the system operating temperature, power-supply voltage, common-mode voltage, and semiconductor processing. The changes in Z_O due to these varying application factors were presented in this article over the full operating range of the PGA900. The results from the individual parameters were used to determine the worst-case changes that may occur in a harsh industrial application. The results of the individual application factors along with the worst-case analysis are listed in [Table 1](#). System designers can use this information to create a robust design over the expected application operating conditions.

Table 1. Summary of PGA900 Z_O

Application Factor	Conditions	R_{LOW_F}	C_{LOW_F}	R_{MID_F}	L_O	R_{HIGH_F}	C_{HIGH_F}
Temperature	-45 to 150°C	-49/+575%	-48/+503%	-38/+778%	-22/+51%	-18/+42%	-3/+0%
Power supply	3.3 to 30 V	-32/+24%	-1/+7%	-6/+1%	-10/+2%	-9/+1%	-4/+2%
Common-mode voltage	0.24 to 1.2 V	-97/+22%	-1/+20%	-0/+3%	-0/+14%	-10/+0%	-0/+21%
Process variation	Weak-strong	-93/+22%	-58/+92%	-25/+38%	-11/+2%	-2/+4%	-9/13%
Worst case	Temperature, Process	-95/+22%	-100/+907%	-55/+1594%	-32/+76%	-19/+45%	-12/+13%

8 References

1. John V. Wait, etc., *Introduction to Operational Amplifier Theory and Applications*, ISBN: 978-0070677654
2. Thomas M. Frederiksen, *Intuitive Operational Amplifiers: From Basics to Useful Applications*, ISBN: 978-0070219670
3. George B. Rutkowski, *Operational Amplifiers: Integrated and Hybrid Circuits*, ISBN: 978-0-471-57718-8
4. Jerald G. Graeme, *Optimizing Op Amp Performance*, ISBN: 978-0071590280
5. Sergio Franco, *Design With Operational Amplifiers And Analog Integrated Circuits*, ISBN: 978-0078028168
6. Miro Oljaca, Collin Wells, Tim Green, *Understanding Open Loop Gain of the PGA900 DAC Gain Amplifier*, [SLDA031](#)
7. TI E2E forum, [Solving Op Amp Stability Issues](#)

Revision History

Changes from Original (May 2015) to A Revision Page

- Corrected graph axis titles 2
 - Added description preceding nominal values..... 3
-

IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, enhancements, improvements and other changes to its semiconductor products and services per JESD46, latest issue, and to discontinue any product or service per JESD48, latest issue. Buyers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All semiconductor products (also referred to herein as "components") are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its components to the specifications applicable at the time of sale, in accordance with the warranty in TI's terms and conditions of sale of semiconductor products. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by applicable law, testing of all parameters of each component is not necessarily performed.

TI assumes no liability for applications assistance or the design of Buyers' products. Buyers are responsible for their products and applications using TI components. To minimize the risks associated with Buyers' products and applications, Buyers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right relating to any combination, machine, or process in which TI components or services are used. Information published by TI regarding third-party products or services does not constitute a license to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of significant portions of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of TI components or services with statements different from or beyond the parameters stated by TI for that component or service voids all express and any implied warranties for the associated TI component or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Buyer acknowledges and agrees that it is solely responsible for compliance with all legal, regulatory and safety-related requirements concerning its products, and any use of TI components in its applications, notwithstanding any applications-related information or support that may be provided by TI. Buyer represents and agrees that it has all the necessary expertise to create and implement safeguards which anticipate dangerous consequences of failures, monitor failures and their consequences, lessen the likelihood of failures that might cause harm and take appropriate remedial actions. Buyer will fully indemnify TI and its representatives against any damages arising out of the use of any TI components in safety-critical applications.

In some cases, TI components may be promoted specifically to facilitate safety-related applications. With such components, TI's goal is to help enable customers to design and create their own end-product solutions that meet applicable functional safety standards and requirements. Nonetheless, such components are subject to these terms.

No TI components are authorized for use in FDA Class III (or similar life-critical medical equipment) unless authorized officers of the parties have executed a special agreement specifically governing such use.

Only those TI components which TI has specifically designated as military grade or "enhanced plastic" are designed and intended for use in military/aerospace applications or environments. Buyer acknowledges and agrees that any military or aerospace use of TI components which have **not** been so designated is solely at the Buyer's risk, and that Buyer is solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI has specifically designated certain components as meeting ISO/TS16949 requirements, mainly for automotive use. In any case of use of non-designated products, TI will not be responsible for any failure to meet ISO/TS16949.

Products

Audio	www.ti.com/audio
Amplifiers	amplifier.ti.com
Data Converters	dataconverter.ti.com
DLP® Products	www.dlp.com
DSP	dsp.ti.com
Clocks and Timers	www.ti.com/clocks
Interface	interface.ti.com
Logic	logic.ti.com
Power Mgmt	power.ti.com
Microcontrollers	microcontroller.ti.com
RFID	www.ti-rfid.com
OMAP Applications Processors	www.ti.com/omap
Wireless Connectivity	www.ti.com/wirelessconnectivity

Applications

Automotive and Transportation	www.ti.com/automotive
Communications and Telecom	www.ti.com/communications
Computers and Peripherals	www.ti.com/computers
Consumer Electronics	www.ti.com/consumer-apps
Energy and Lighting	www.ti.com/energy
Industrial	www.ti.com/industrial
Medical	www.ti.com/medical
Security	www.ti.com/security
Space, Avionics and Defense	www.ti.com/space-avionics-defense
Video and Imaging	www.ti.com/video

TI E2E Community

e2e.ti.com